


<b>Search Notes</b>  	<b>Application/Control No.</b>  10567701	<b>Applicant(s)/Patent Under Reexamination</b>  CHEN ET AL.
	<b>Examiner</b>  JAE Y LEE	<b>Art Unit</b>  2419

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
370/310,313,349,389,401 (US-PGPUB;USPAT)	9/16/2008 (Updated on 3/24/2009)	JL
EAST (US-PGPUB;USPAT;USOCR;FPRS;EPO;JPO;DERWENT;IBM_TDB)-See Search History Printout	9/16/2008 (Updated on 3/24/2009)	JL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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